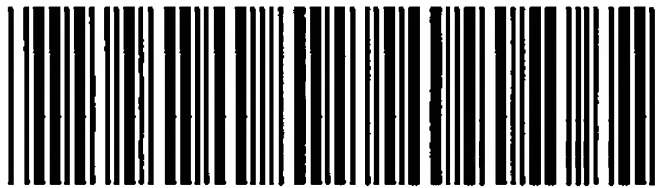


<b>Search Notes</b>  	<b>Application/Control No.</b>  10601653	<b>Applicant(s)/Patent Under Reexamination</b>  OHTSUKA, SHUICHI
	<b>Examiner</b>  Bayat, Ali	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	115,218,219,224,229,181,170,190,198,305	1/18/07	A.B
348	231.2	1/18/07	A.B
358	450	1/18/07	A.B
	updated above	6/13/07	A.B

SEARCH NOTES		
Search Notes	Date	Examiner
EAST ( US-PGPUB;USPA; EPO;JPO;DERWENT; IBM-TDB), and IEEE XPLORE, and Inventor name searched, see the search history print out.	1/18/07	A.B
updated above	6/13/07	A.B

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
US-PGPUB	USPGPUB SEE the text search history	1/20/07	A.B
	updated above	6/13/07	A.B